

HD Supercell efficiency measurements in Liquid Argon @ Milano-Bicocca: MC computed geometric acceptance

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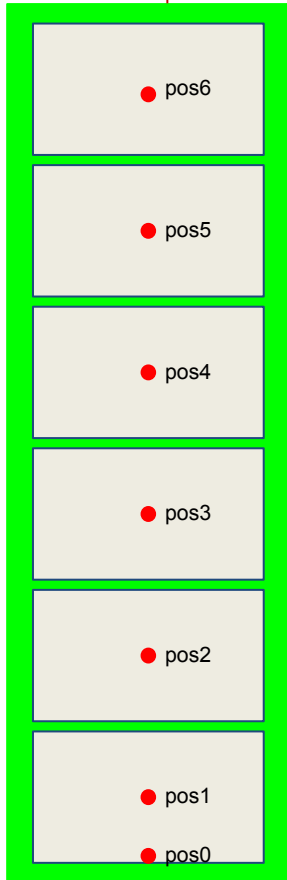
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HD-XA Supercell PDE measurements & data analysis

- Available alpha-source scanning data of XA configurations :
 - HG, FE, FG (pDUNE nomenclature)
 - First PDE analysis: C. Massari master thesis.
 - Last PDE update: 25/10/2022
- **NEW** (done)
 - XA HD SC simulation (MiB PDE measurement setup)
 - **geometric acceptance** (this talk)
 - comparison between analytical and MC computation
- **NEW** (work in progress): Refinement of data analysis
 - signal calibration
 - peak finding algorithm
 - gain computation
 - wfm deconvolution by Gaus+Wiener for the muon analysis (LAr purity corrections)

Method & Data taking

pos-mu



z-scanning of the SC with the ^{241}Am α (5.480 MeV) source at the following positions:

1. **pos0**: (the lowest possible): ~ 2 cm above the flange.
2. **pos1, 2, 3, 4, 5, 6**: the center of each dichroic filter.
Acquired: $10^4 \times 4$ wfms; 20 μs length; ~ 5 μs pretrigger.
3. Source at the topmost position (~ 49 cm from the flange) and \sim out of LAr:
 - one **μ run** ($10^4 \times 4$ events; 20 μs , 5 μs pretrigger)
 - one **s.p.h.e. run** ($10^4 \times 8$ events; 20 μs length; 1.6 μs pretrigger)

Source-to-dichroic filter distance: (55 +/- 1) mm.

Noise Run: $V_{\text{bias}} = V_{\text{bd}} - 1\text{V}$ for FFT and filter shape&cutoff definition

Solid angle: analytical computation

Calculated analytically as the angle of the vertex of a pyramid with a rectangular base (the SC)

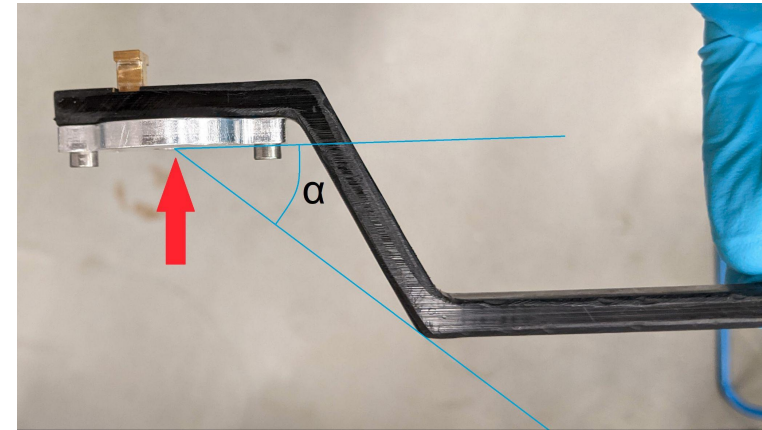
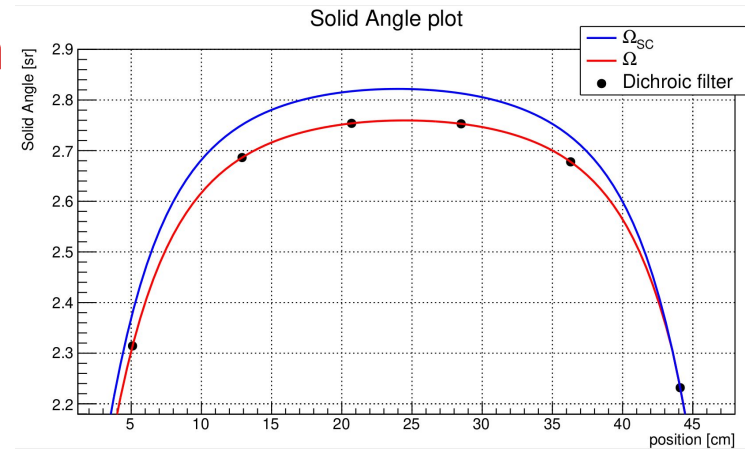
$$\Omega_{SC}(x) = 2 \arctan \left(\frac{abh}{2R_1(x^2 + h^2) + 2R_2[x(x-b) + h^2]} \right) + 2 \arctan \left(\frac{abh}{2R_1(x(x-b) + h^2) + 2R_2[(x-b)^2 + h^2]} \right)$$

The source holder covers part of the solid angle

$$\Omega_s(x) = 2 \arctan \left(\frac{wh(b-x-h \cot \alpha)}{2R_3[h \cot \alpha(b-x) + h^2] + 2R_4[(h \cot \alpha)^2 + h^2]} \right) + 2 \arctan \left(\frac{wh(b-x-h \cot \alpha)}{2R_3[(b-x)^2 + h^2] + 2R_4[h \cot \alpha(b-x) + h^2]} \right)$$

The solid angle is thus:

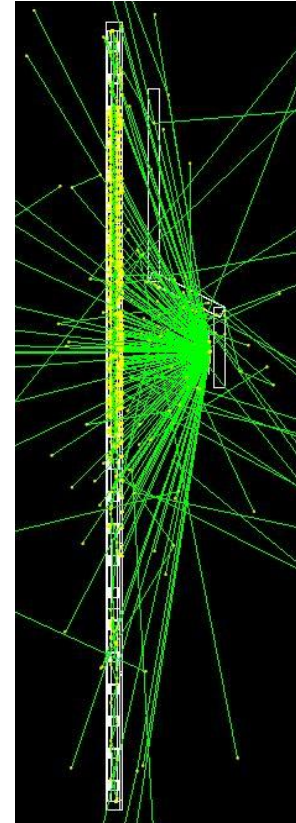
$$\Omega(x) = \begin{cases} \Omega_{SC}(x) - \Omega_s(x) & \text{if } x < b - h \cot \alpha \\ \Omega_{SC}(x) & \text{if } x \geq b - h \cot \alpha \end{cases}$$



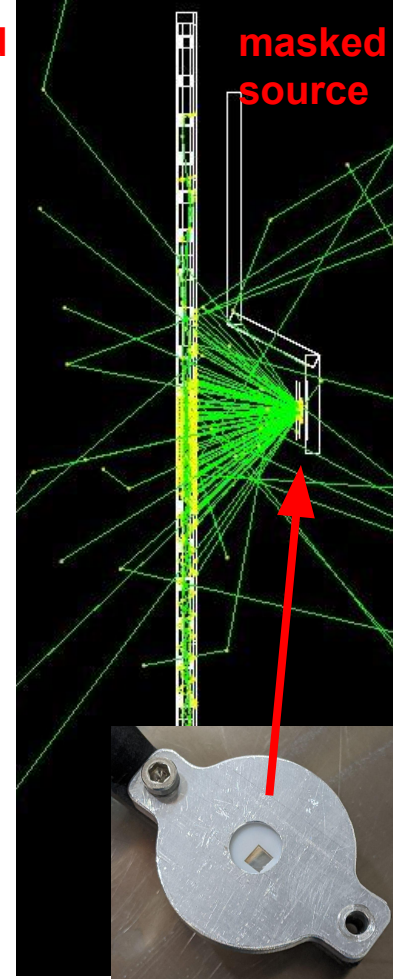
MC computed geometric acceptance

- computed via a geant4 simulation
 - geometry takes into account also the source holder and teflon mask (previously only the source holder arm was modeled)
 - solid angle obtained from the ratio of photons hitting the pTP deposit over the scintillation photons
 - $\Omega = (\gamma_{\text{pTP}}/\gamma_{\text{scint}})*4\pi$

unmasked
source

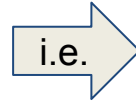


masked
source

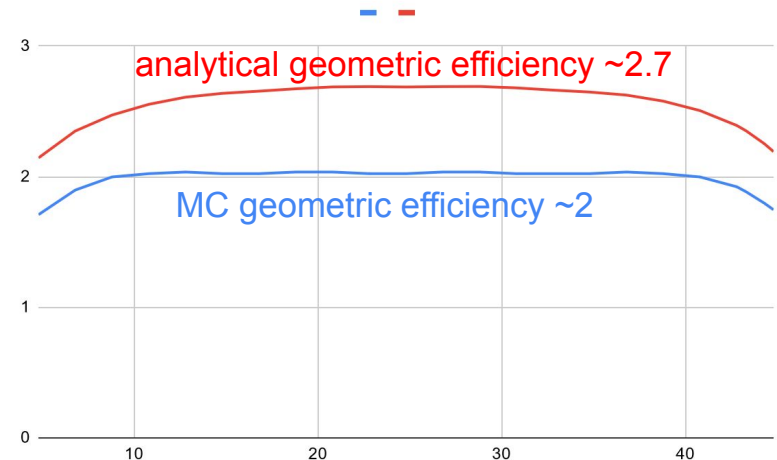


MC computed geometric acceptance

- the MC result is lower than the analytical computation with the same configuration (holder arm only)
 - possible difference in the geometry
 - effects from absorption and scattering in IAr
- adding source geometry, holder and teflon mask, the geometric acceptance decreases from a peak of **2.7** steradians to **2**



position	MC sim	analytical
4th dichroic	2.43	2.69



MC geometric acceptance correction

- preliminary: all data must be reanalyzed

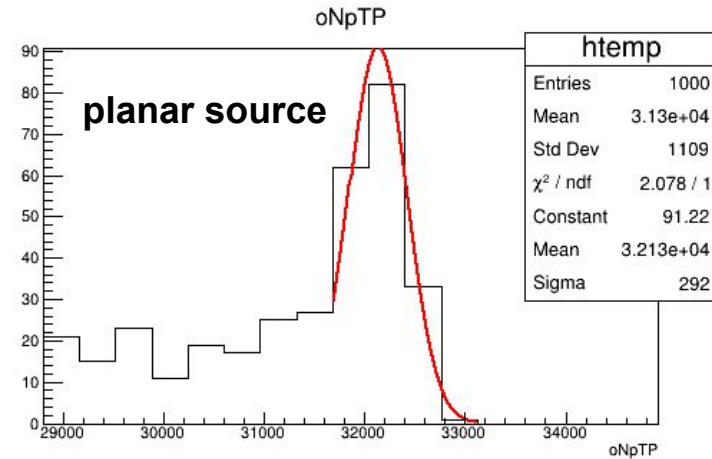
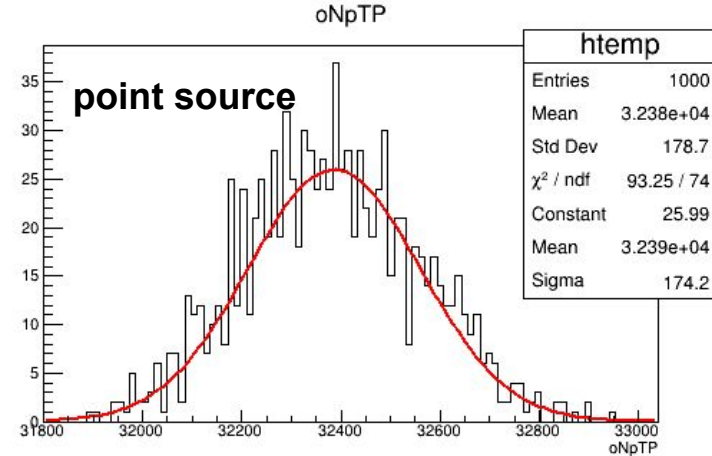
		OV	PDE	Uncorrected ϵ_{XA}	Measured Xtalk	P_{LAr}	Position systematic	Corrected ϵ_{XA} x talk only	Corrected ϵ_{XA} x talk and P_{LAr}	Corrected geometric acceptance (MC)
this work	HPK** & G2P	3.0V	50%	1.94 (0.03)	6.62%	TBD	0.08	1.82 (0.08)		2.5 (0.16)
	FBK*** & G2P	4.5V	45%	1.72 (0.03)	15.7%	1.06	0.10	1.49 (0.10)	1.58 (0.10)	2.1 (0.23)
	FBK*** & Eljen	4.5V	45%	1.50 (0.02)	15.7%	TBD	0.06	1.29 (0.07)		1.8 (0.18)
JINST work	HPK commercial*	2.7V	45%	3.5 (0.1)	22%			2.9 (0.1)		

Point source vs Planar source

The geometric acceptance has been computed simulating:

- first a point-like source
 - faster to run
- then a planar source (~5mm diameter) → a low energy tail shows up and the peak mean is found ~4% lower
 - simulations can be re-run to take this effect into account

source	point-like	planar	planar/point
peak mean	3.238e+04	3.13e+4	96.6%



Point source vs Planar source

source	point-like	planar	planar/point
peak mean	417	397	95.2%

- the detected photons spectrum shape is similar to the one from measurements

